

Search Notes

Application/Control No.

10/634,779

Examiner

Elizabeth Ivey

Applicant(s)/Patent under
Reexamination

OTOSAKA ET AL.

Art Unit

1775

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-----------------|------------|------|
| See EAST Search | 5/21/2006 | EDI |
| Updated Search | 12/12/2006 | EDI |
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